



N 沟道增强型场效应晶体管 N-CHANNEL MOSFET FHP8N65B/FHF8N65B

主要参数 MAIN CHARACTERISTICS

ID	8A
VDSS	650 V
Rdson-typ (@Vgs=10V)	0.95Ω
Qg-typ	37nC

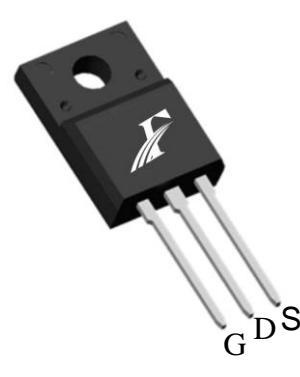
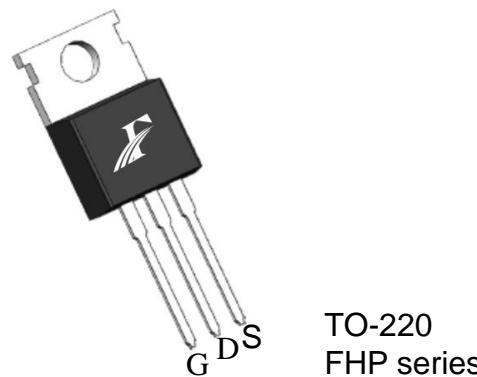
产品特性 FEATURES

低栅极电荷	Low gate charge
低 Crss (典型值 13pF)	Low Crss (typical 13pF)
开关速度快	Fast switching
100% 经过雪崩测试	100% avalanche tested
高抗 dv/dt 能力	Improved dv/dt capability
RoHS 产品	RoHS product

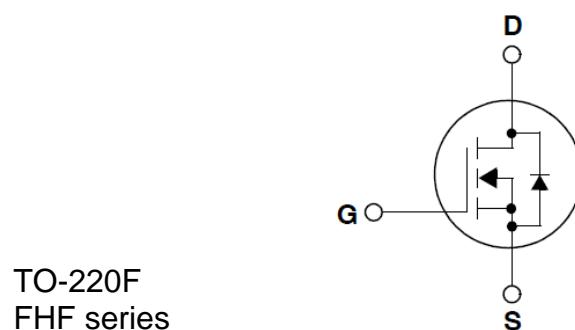
用途 APPLICATIONS

高频开关电源	High efficiency switch mode power supplies
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封装形式 Package



等效电路 Equivalent Circuit



绝对最大额定值 ABSOLUTE RATINGS (Tc=25°C)

项目 Parameter	符号 Symbol	数值 Value		单位 Unit
		FHP8N65B	FHF8N65B	
最高漏极—源极直流电压 Drain-Source Voltage	VDS	600		V
连续漏极电流* Drain Current -continuous *	I _D (T _c =25°C)	8		A
	I _D (T _c =100°C)	4.8		A
最大脉冲漏极电流 (注 1) Drain Current – pulse (note 1)	I _{DM}	32		A
最高栅源电压 Gate-Source Voltage	V _{GS}	±30		V
单脉冲雪崩能量 (注 2) Single Pulsed Avalanche Energy (note 2)	E _{AS}	180		mJ
雪崩电流 (注 1) Avalanche Current (note 1)	I _{AS}	6		A
重复雪崩能量 (注 1) Repetitive Avalanche Current (note 1)	E _{AR}	43		mJ
二极管反向恢复最大电压变化速率 (注 3) Peak Diode Recovery dv/dt (note 3)	dv/dt	5.0		V/ns
耗散功率 Power Dissipation	P _D (T _C =25°C)	107	64	W
	-Derate above 25°C	0.7	0.34	W/°C
最高结温及存储温度 Operating and Storage Temperature Range	T _J , T _{STG}	-55~+150		°C
引线最高焊接温度 Maximum Lead Temperature for Soldering Purposes	T _L	300		°C

*漏极电流由最高结温限制

*Drain current limited by maximum junction temperature

电特性 ELECTRICAL CHARACTERISTICS

项目 Parameter	符号 Symbol	测试条件 Tests conditions	最小 Min	典型 Typ	最大 Max	单位 Units	
关态特性 Off -Characteristics							
漏一源击穿电压 Drain-Source Voltage	BVDSS	ID=250μA, VGS=0V	650	-	-	V	
击穿电压温度特性 Breakdown Voltage Temperature Coefficient	ΔBVDSS/Δ TJ	ID=250μA, referenced to 25°C	-	0.6	-	V/°C	
零栅压下漏极漏电流 Zero Gate Voltage Drain Current	IDSS	VDS=650V, VGS=0V, TC=25°C	-	-	1	μA	
		VDS=650V, TC=125°C	-	-	100	μA	
栅极体漏电流 Gate-body leakage current	IGSS (F/R)	VDS=0V, VGS =±30V	-	-	±100	nA	
通态特性 On-Characteristics							
阈值电压 Gate Threshold Voltage	VGS(th)	VDS = VGS , ID=250μA	3	-	4	V	
静态导通电阻 Static Drain-Source On-Resistance	RDS(ON)	VGS =10V , ID=4A	-	0.95	1.15	Ω	
正向跨导 Forward Transconductance	gfs	VDS = 25V, ID=4A (note 4)	-	7	-	S	
动态特性 Dynamic Characteristics							
输入电容 Input capacitance	Ciss	VDS=25V, VGS =0V, f=1.0MHz	-	1110	-	pF	
输出电容 Output capacitance	Coss		-	106	-		
反向传输电容 Reverse transfer capacitance	Crss		-	13	-		
开关特性 Switching Characteristics							
延迟时间 Turn-On delay time	td(on)	VDS=325V, ID=8A, RG=25Ω VGS =10V (note 4, 5)	-	39	-	ns	
上升时间 Turn-On rise time	tr		-	10	-	ns	
延迟时间 Turn-Off delay time	td(off)		-	152	-	ns	
下降时间 Turn-Off Fall time	tf		-	42	-	ns	
栅极电荷总量 Total Gate Charge	Qg	VDS =520V , ID=8A , VGS =10V (note 4, 5)	-	37	-	nC	
栅一源电荷 Gate-Source charge	Qgs		-	5	-	nC	
栅一漏电荷 Gate-Drain charge	Qgd		-	24	-	nC	
漏一源二极管特性及最大额定值 Drain-Source Diode Characteristics and Maximum Ratings							
正向最大连续电流 Maximum Continuous Drain -Source Diode Forward Current	Is		-	-	8	A	
正向最大脉冲电流 Maximum Pulsed Drain-Source Diode Forward Current	ISM		-	-	32	A	
正向压降 Drain-Source Diode Forward Voltage	VSD	VGS=0V, Is=4A	-	0.9	1.4	V	
反向恢复时间 Reverse recovery time	trr	VGS=0V, Is=8A ,dI/dt=100A/μs (note 4)	-	601	-	ns	
反向恢复电荷 Reverse recovery charge	Qrr		-	2.3	-	μC	

热特性 THERMAL CHARACTERISTIC

项目 Parameter	符号 Symbol	FHP8N65B	FHF8N65B	单位 Unit
结到管壳的热阻 Thermal Resistance, Junction to Case	R _{th(j-c)}	1.17	1.95	°C/W
结到环境的热阻 Thermal Resistance, Junction to Ambient	R _{th(j-A)}	60	62.5	°C/W

注释:

- 1: 脉冲宽度由最高结温限制
- 2: L=10mH, I_{AS}=6A, V_{DD}=50V, R_G=25 Ω,起始结温 T_J=25°C
- 3: I_{SD} ≤ 8A, di/dt ≤ 100A/μs, V_{DD}≤BV_{DSS},起始结温 T_J=25°C
- 4: 脉冲测试: 脉冲宽度 ≤300μs,占空比≤2%
- 5: 基本与工作温度无关

Notes:

- 1: Pulse width limited by maximum junction temperature
- 2: L=10mH, I_{AS}=6A, V_{DD}=50V, R_G=25 Ω,Starting T_J=25°C
- 3: I_{SD} ≤ 8A,di/dt ≤ 100A/μs, V_{DD}≤BV_{DSS}, Starting T_J=25°C
- 4: Pulse Test: Pulse Width ≤300μs,Duty Cycle≤2%
- 5: Essentially independent of operating temperatur

特性曲线 Typical Characteristics

Figure 1. Output Characteristics ($T_J = 25^\circ\text{C}$)

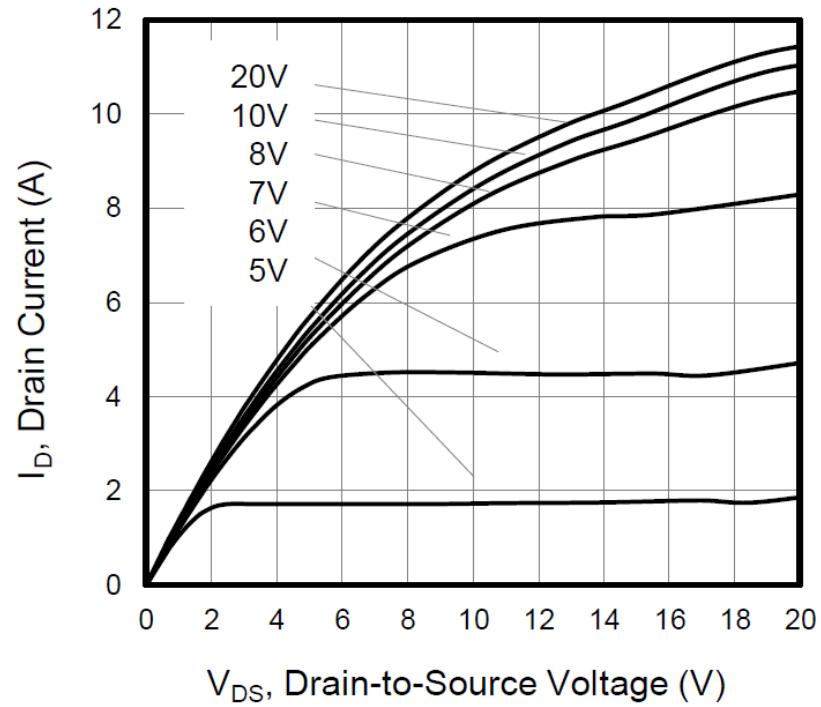


Figure 2. Body Diode Forward Voltage

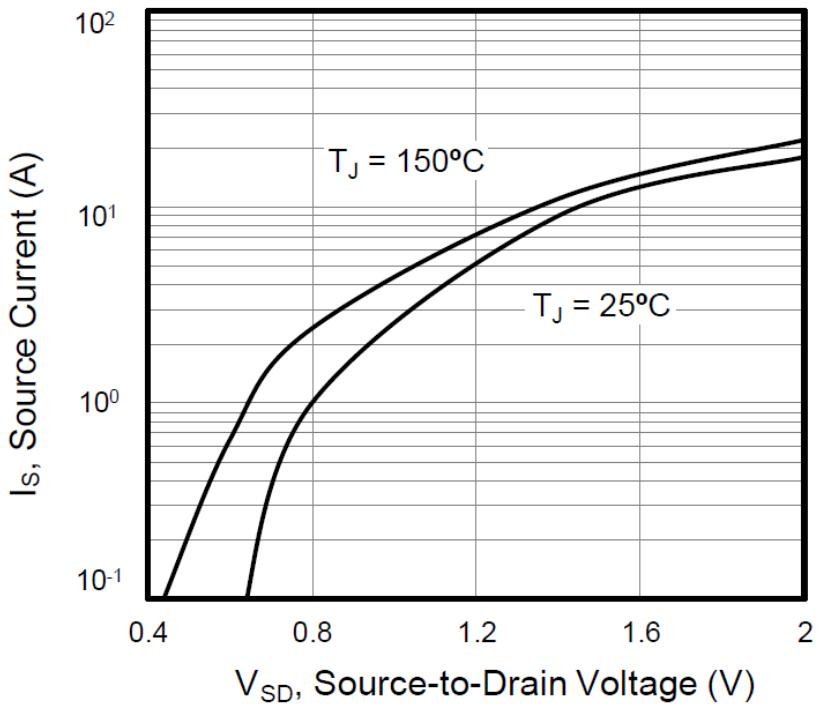


Figure 3. Drain Current vs. Temperature

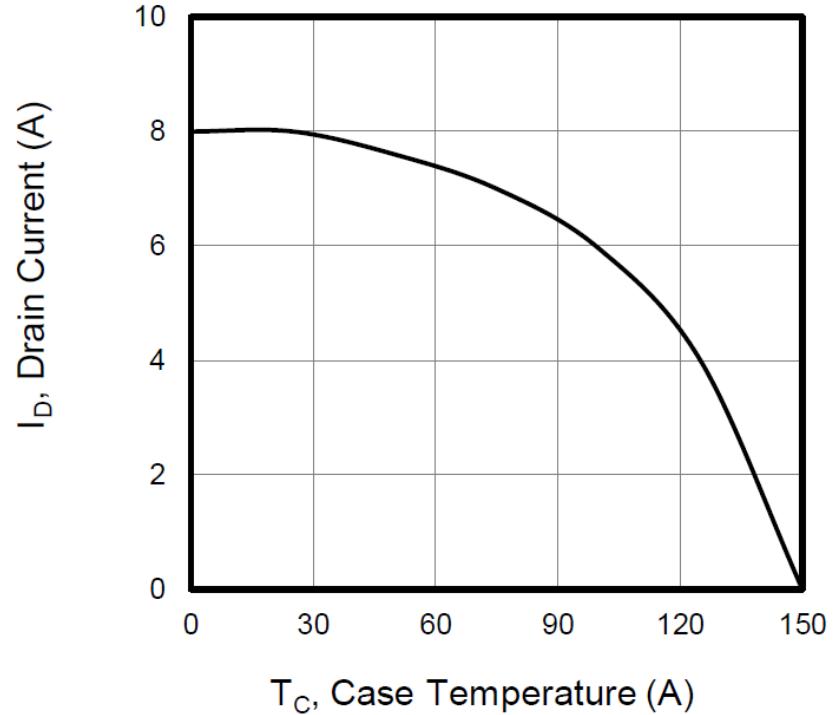


Figure 4. BV_{DSS} Variation vs. Temperature

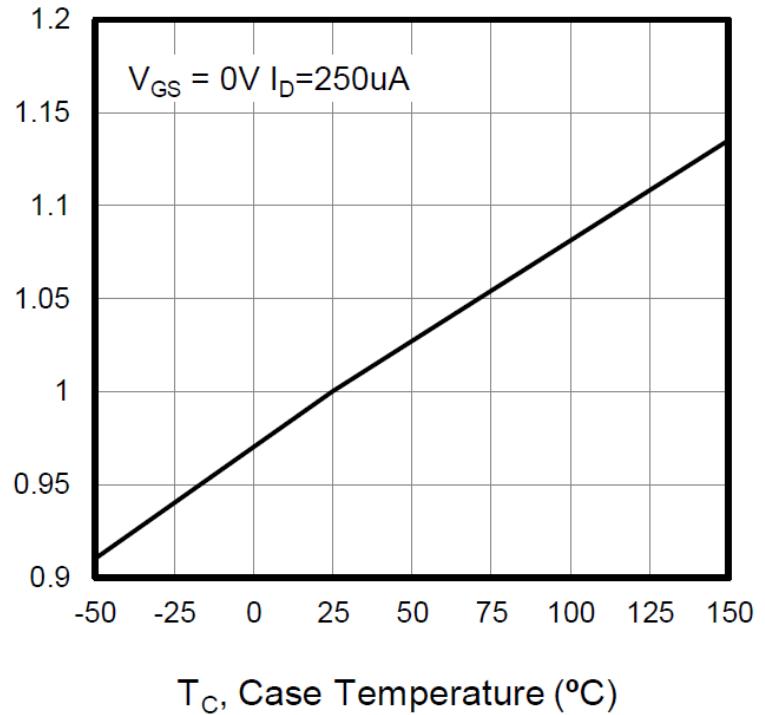


Figure 5. Transfer Characteristics

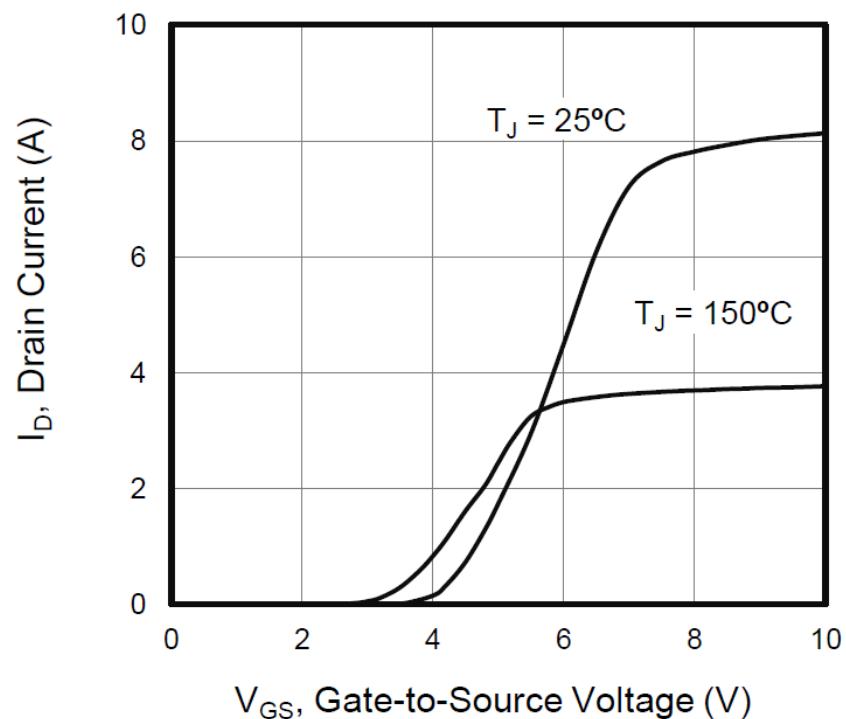


Figure 6. On-Resistance vs. Temperature

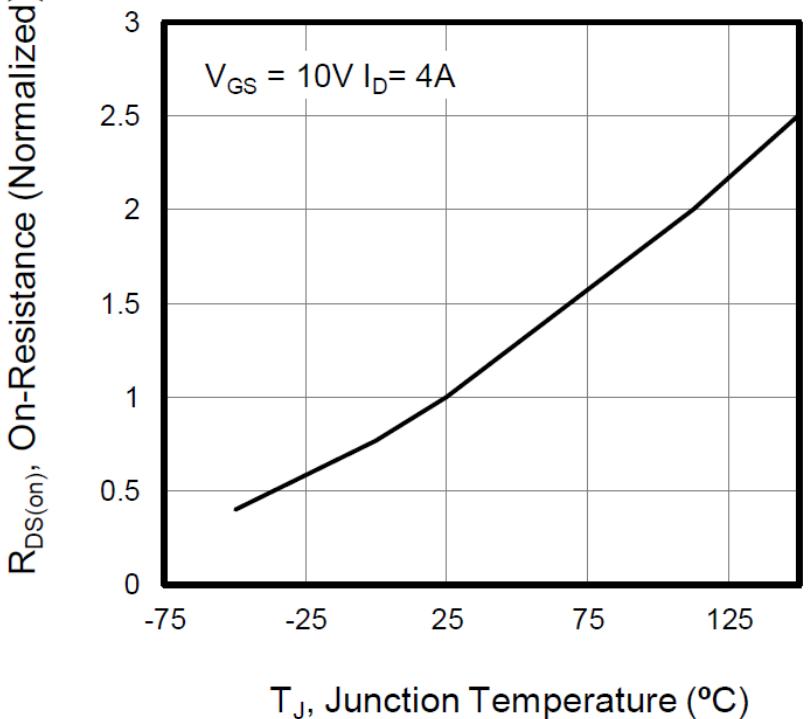


Figure 7. Capacitance

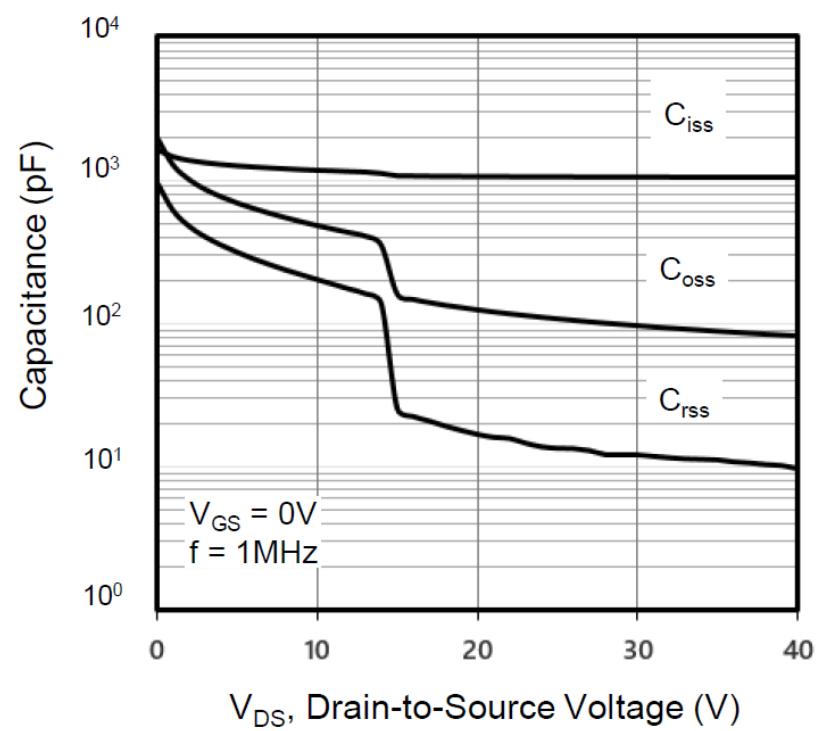


Figure 8. Gate Charge

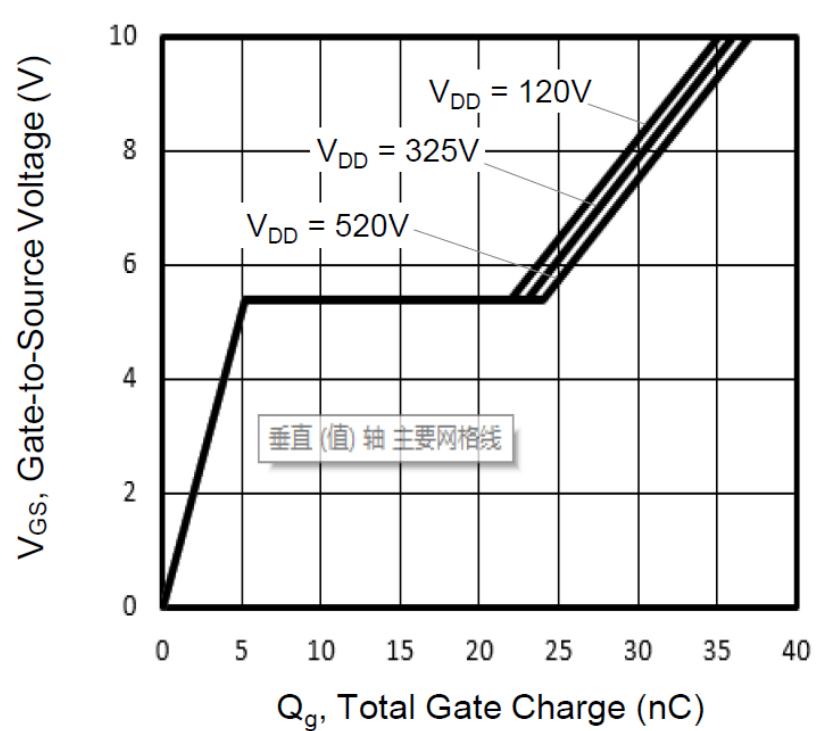


Figure 9. Transient Thermal Impedance

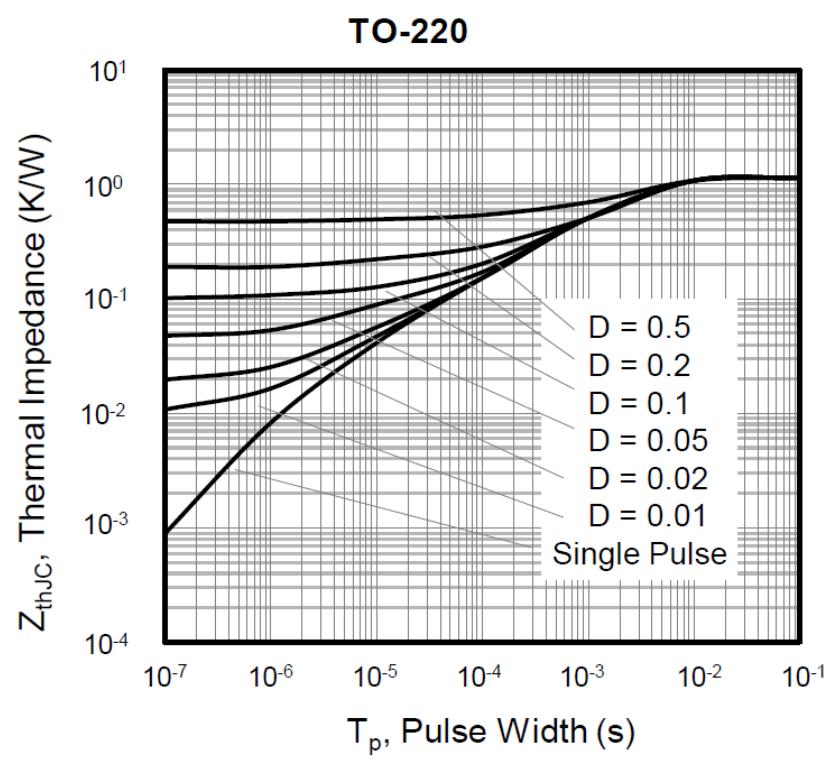


Figure 10. Transient Thermal Impedance

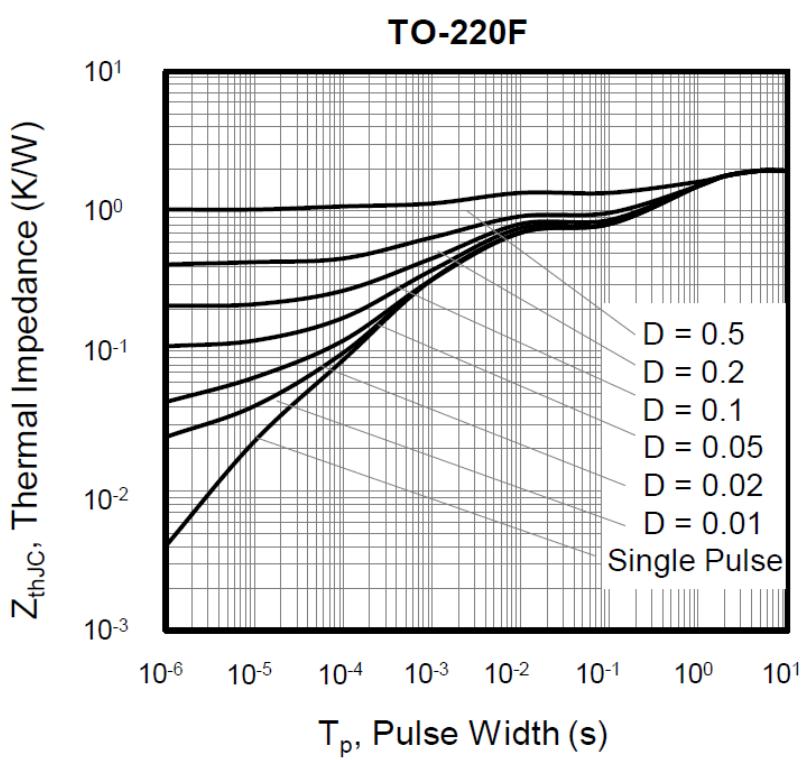


Figure A: Gate Charge Test Circuit and Waveform

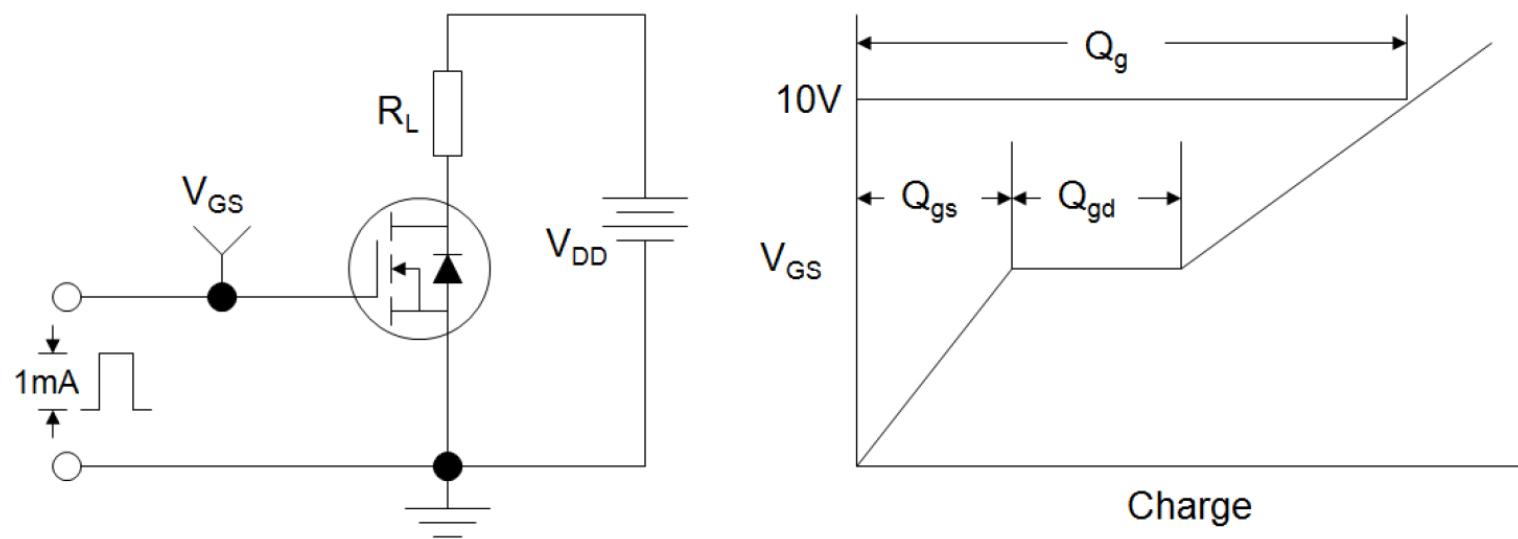


Figure B: Resistive Switching Test Circuit and Waveform

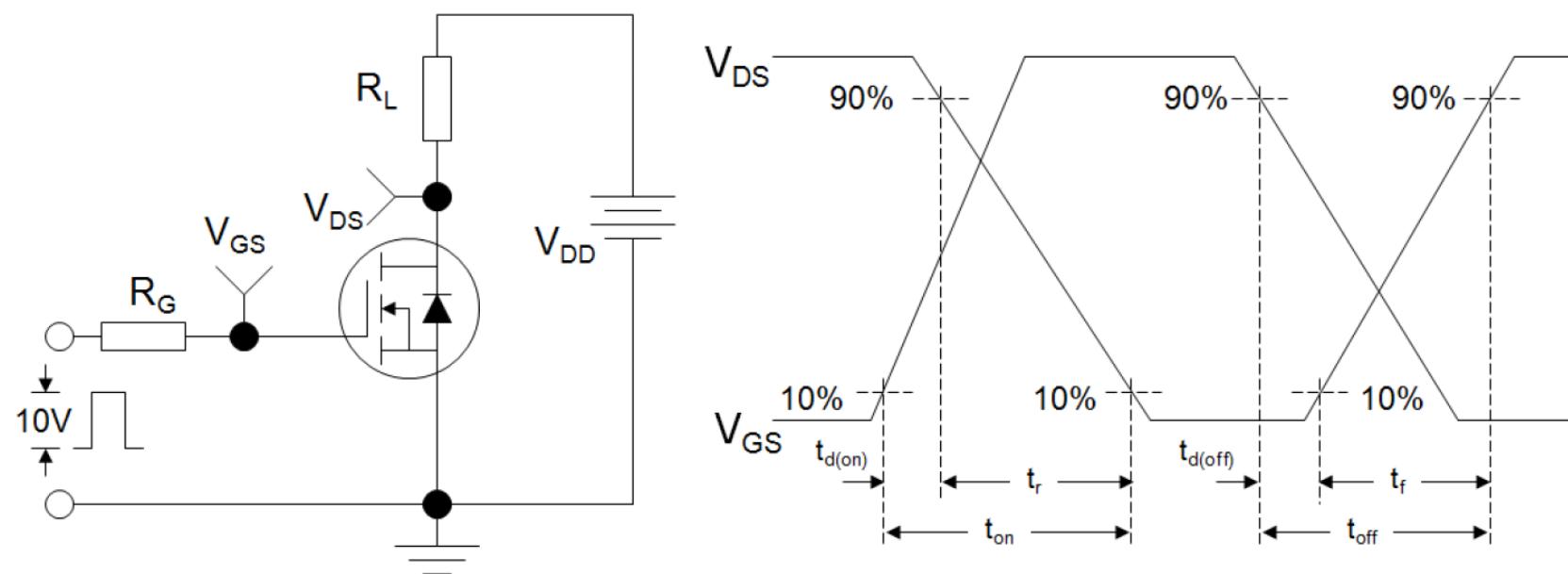
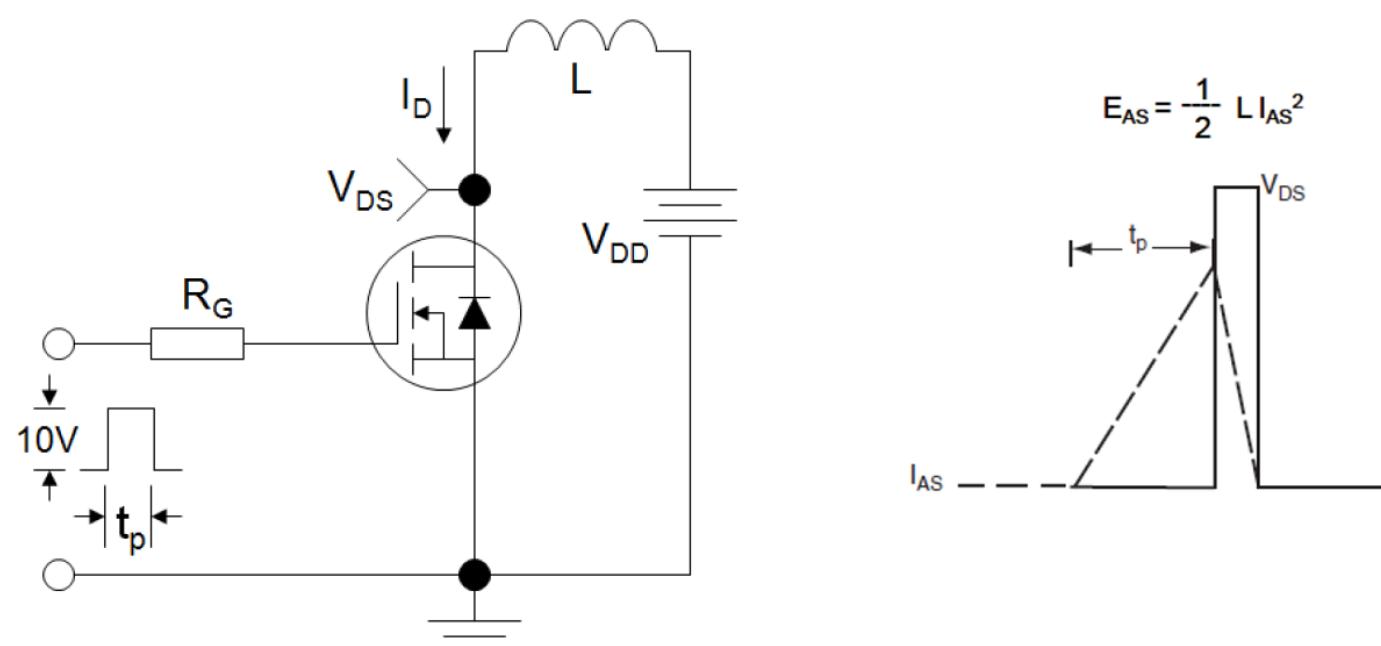
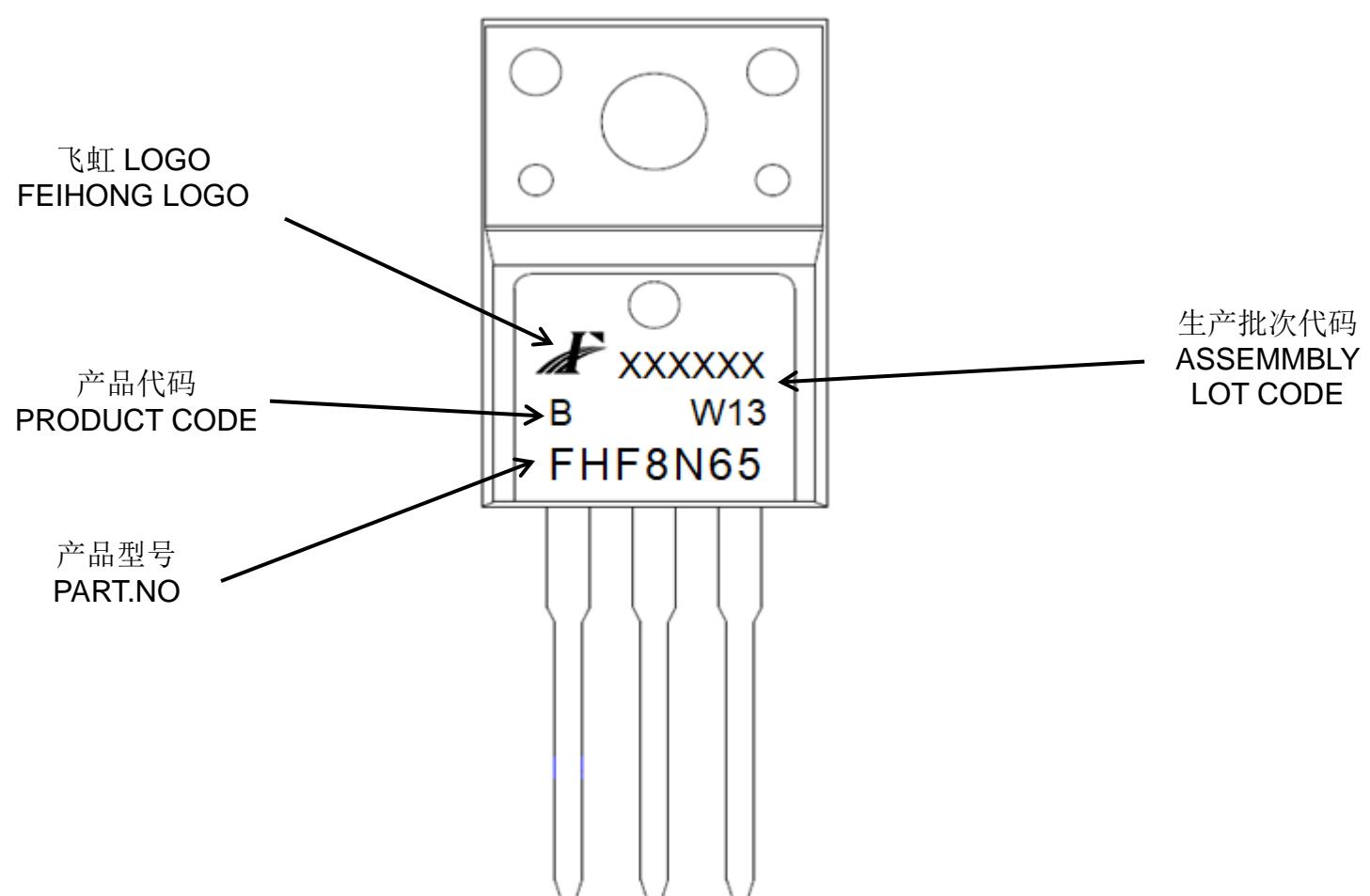
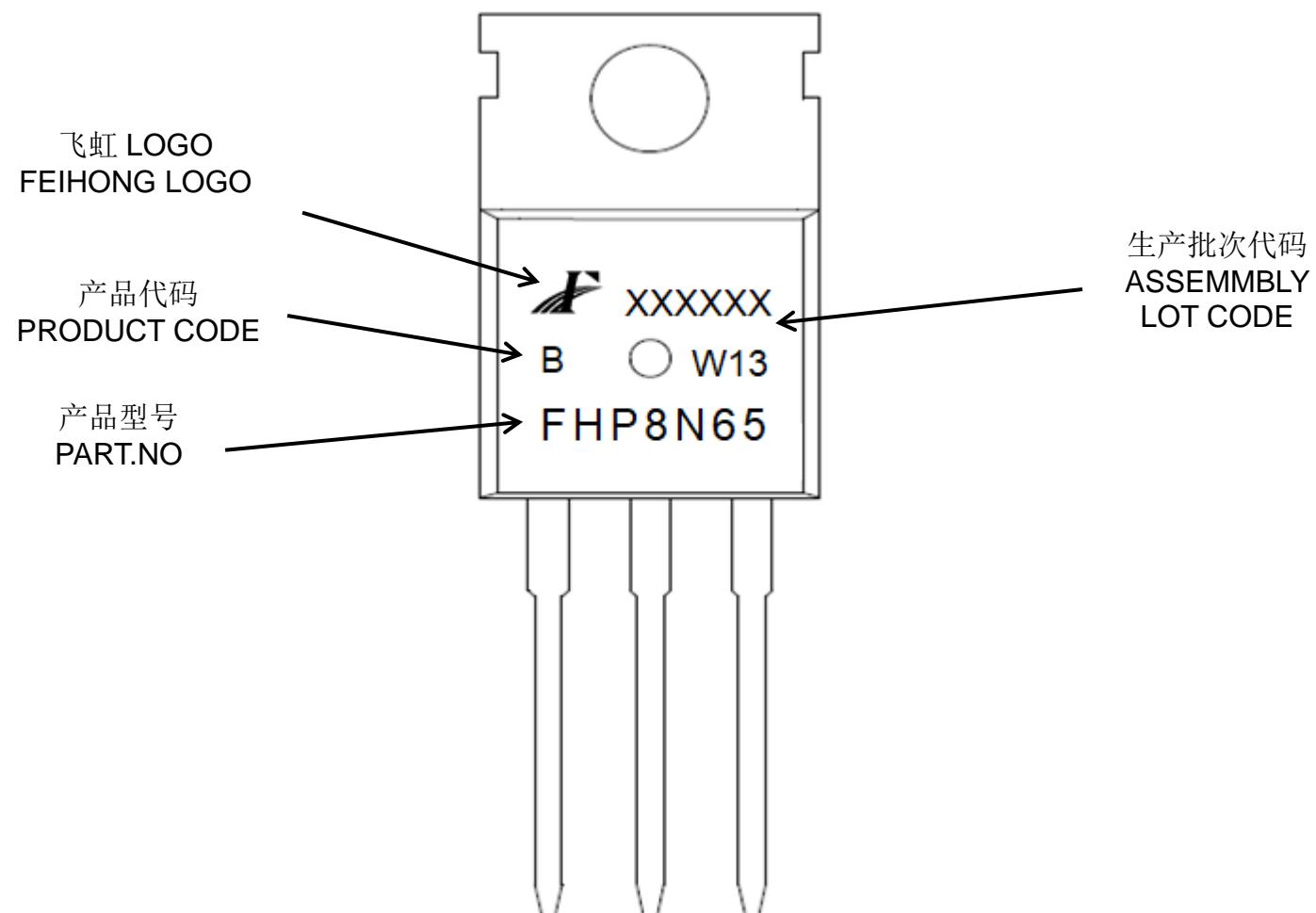


Figure C: Unclamped Inductive Switching Test Circuit and Waveform



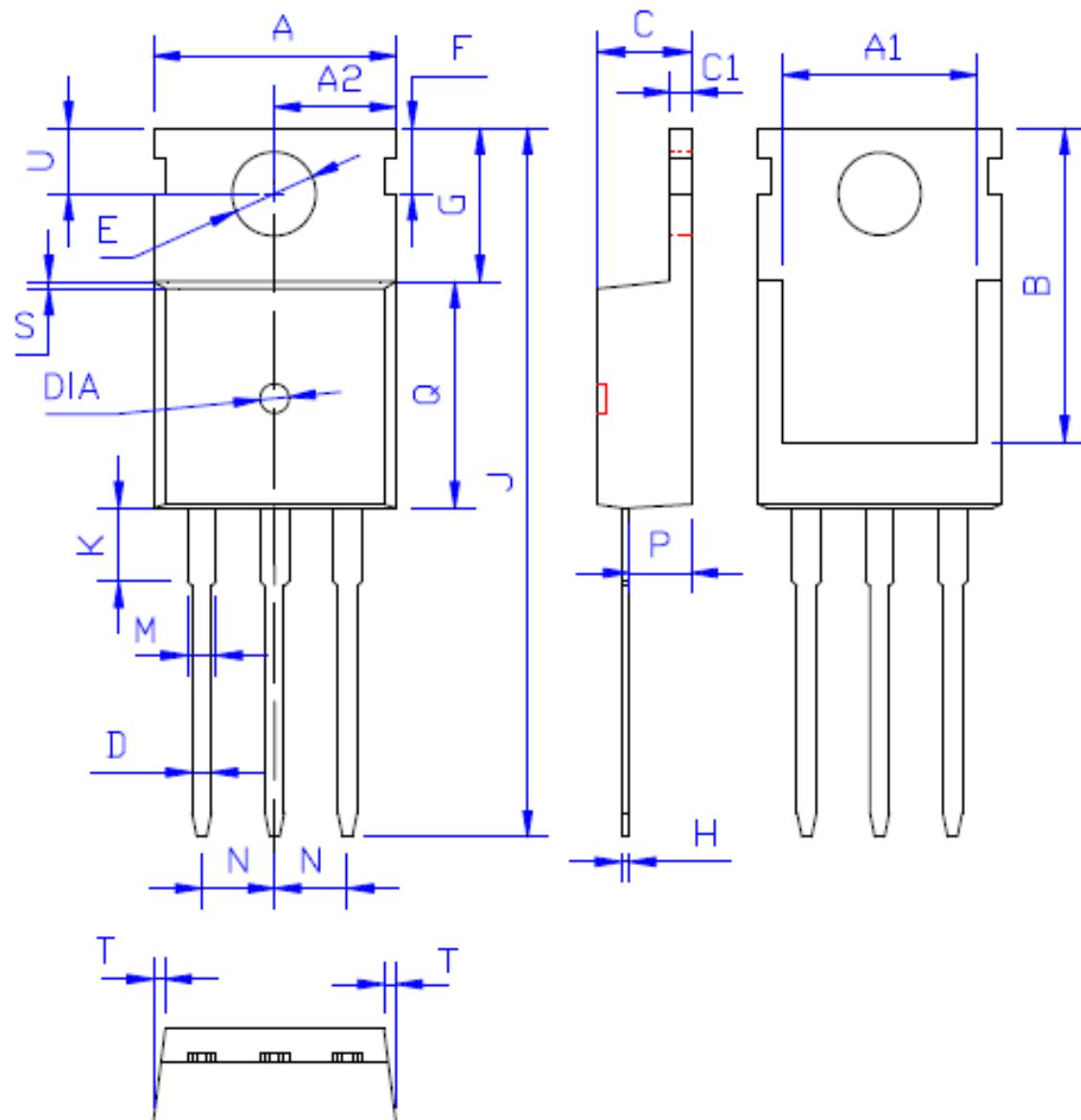
印记 Marking:



外形尺寸:

Package Dimension:

TO-220



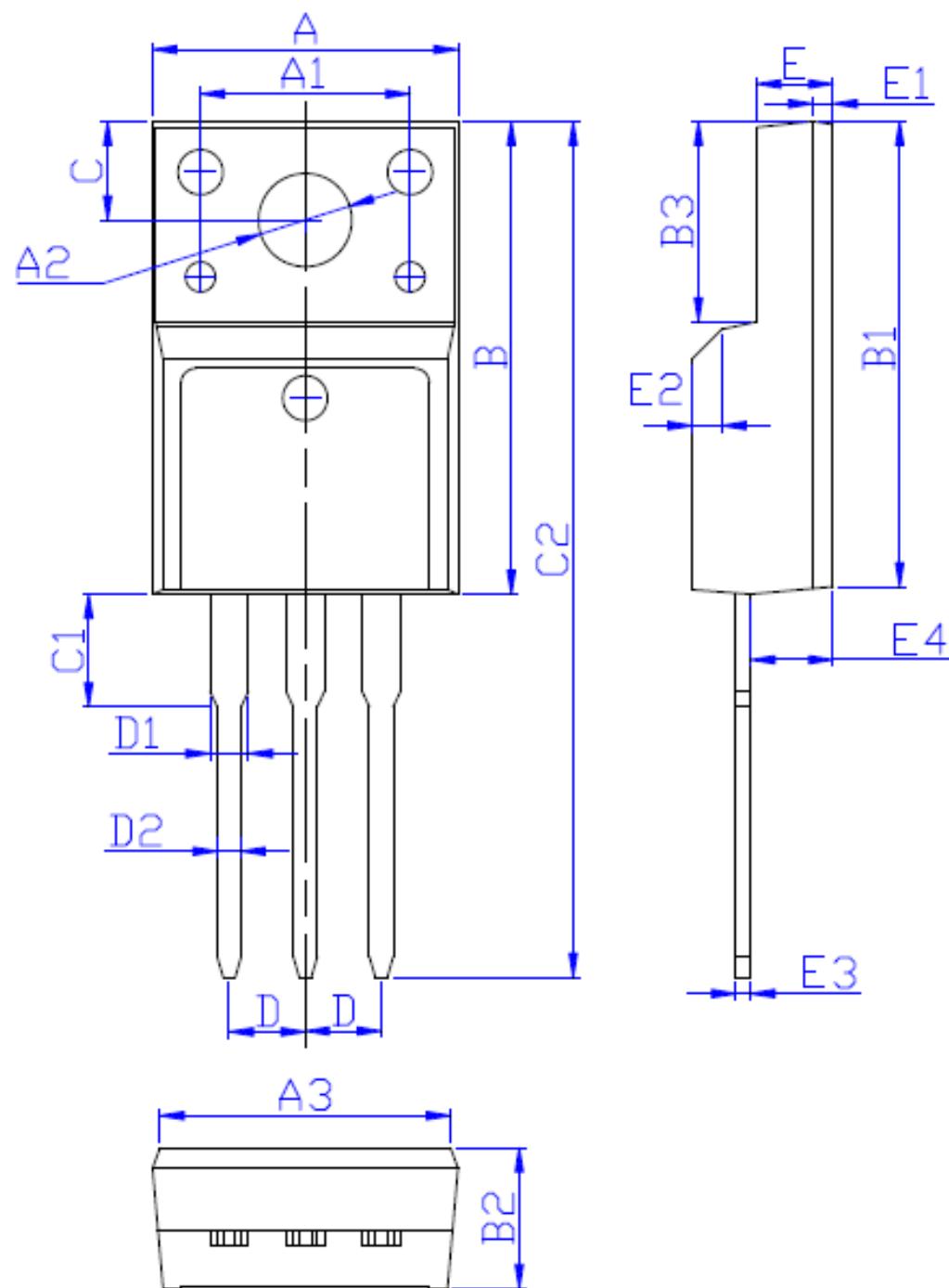
DIM	MILLIMETERS
A	10.00±0.30
A1	8.00±0.30
A2	5.00±0.30
B	13.20±0.40
C	4.50±0.20
C1	1.30±0.20
D	0.80±0.20
E	3.60±0.20
F	3.00±0.30
G	6.60±0.40
H	0.50±0.20
J	28.88±0.50
K	3.00±0.30
M	1.30±0.30
N	Typical 2.54
P	2.40±0.40
Q	9.20±0.40
S	0.25±0.15
T	0.25±0.15
U	2.80±0.30
DIA	宽 1.50±0.10 深 0.50 MAX

(Unit: mm)

外形尺寸:

Package Dimension:

TO-220F



DIM	MILLIMETERS
A	10.16 ± 0.30
A1	7.00 ± 0.20
A2	3.12 ± 0.20
A3	9.70 ± 0.30
B	15.90 ± 0.50
B1	15.60 ± 0.50
B2	4.70 ± 0.30
B3	6.70 ± 0.30
C	3.30 ± 0.25
C1	3.25 ± 0.30
C2	28.70 ± 0.50
D	Typical 2.54
D1	1.47 (MAX)
D2	0.80 ± 0.20
E	2.55 ± 0.25
E1	0.70 ± 0.25
E2	$1.0 \times 45^\circ$
E3	0.50 ± 0.20
E4	2.75 ± 0.30

(Unit:mm)